STUI ROCK PUT/PTC 1 FEB 2005

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			265999US3PCT		New U.S. PCT Application Based on PCT/JP03/10574			
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Kenji YASUDA, et al.					
				FILING DATE Herewith		GROUP			
				U.S. PATENT DOCUMENTS		<u> </u>			
EXAMINER		DOCUMENT		NAME	CLASS	SUB		NG DATE	
INITIAL		NUMBER	DATE	IVAIVIE		CLASS	IF APF	PROPRIATE	
	AA								
	AB	· · · · · · · · · · · · · · · · · · ·	_		-				
	AC								
	AD							 -	
	AE	<u> </u>			_				
	AF	· · · · · · · · · · · · · · · · · · ·	- 		+	\vdash			
	AG								
	AH		 		-				
	AI AJ				+				
	AK		-						
-	AL								
	AM				_				
	AN				1				
-	1,	J	FC	DREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY		1	TRANSLATION YES NO		
/NA/	AO	99/33559	07/08/99	WO (equivalent of US 6368871)				NO	
/NA/	AP	99/47922	09/23/99	WO (equivalent of US 6197575)				NO	
/NA/	AQ	2002-136287	05/14/02	JP				NO	
	AR								
	AS					Ļ			
	AT				···	 		<u> </u>	
	AU			<u> </u>		 			
	AV	<u> </u>			-4 Dan	1			
	T	OTHER I	REFERENCES	(Including Author, Title, Date, Pertine	ent Pages, (s.c.)			
	AW								
	AX				 -				
	AY		-				,		
	AZ				Add	titional Ref	erences st	neet(s) attached	
Examiner	/Nina Archie/					Date Considered 07/01/2007			
*Examiner: I	nitial if	reference is considere	d. whether or n	ot citation is in conformance with MPEP m with next communication to applicant.	609; Draw	line through	n citation if	not in	